## Notice of References Cited Application/Control No. 10/776,902 Examiner John Chavis Applicant(s)/Patent Under Reexamination KURZ ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2005/0071853	03-2005	Jones et al.	719/328
*	В	US-2004/0230947	11-2004	Bales et al.	717/110
*	O	US-2006/0053376	03-2006	Ng et al.	715/742
*	D	US-2003/0167315	09-2003	Chowdhry et al.	709/218
*	Ε	US-2004/0183831	09-2004	Ritchy et al.	345/762
*	F	US-7,062,511	06-2006	Poulsen, Thomas J.	707/104.1
*	G	US-2002/0169852	11-2002	Schaeck, Thomas	709/218
*	Н	US-2005/0132023	06-2005	Cazzolla et al.	709/219
	ì	US-			
	٦	US-			
	κ	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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